



1200 V 75 mΩ SiC MOSFET

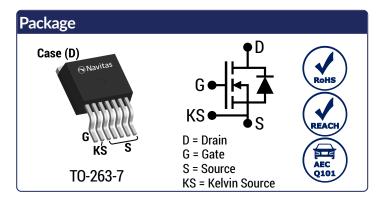
Silicon Carbide MOSFET

Trench-Assisted Planar Technology

 $\begin{array}{lll} V_{DS} & = & 1200 \ V \\ R_{DS(ON)}(Typ.) = & 75 \ m\Omega \\ I_{D}(T_{C} = 100^{\circ}C) & = & 22 \ A \end{array}$

Features

- Gen3F (3rd Generation) Technology
- Most Stable R_{DS(ON)} over Temperature
- Low Coss, Crss and Balanced Ciss/Crss
- Lower Q_{GD} and Balanced R_{G(INT)}
- Electromagnetically Optimized Design
- Robust Body Diode with Low V_F and Low Q_{RR}
- 100% Avalanche (UIL) Tested
- AEC-Q101 Qualified



Advantages

- Superior Performance and Robustness
- Lowest Conduction Losses at all Temperatures
- Lesser Switching Spikes and Lower Losses
- Faster and More Efficient Switching
- Reduced Ringing
- Ease of Paralleling without Thermal Runaway
- Excellent Power Density and System Efficiency
- Enhanced System Reliability

Applications

- Solar Inverters
- EV/HEV Charging
- UPS
- High Voltage DC-DC Converters
- Switched Mode Power Supplies
- Motor Drives
- Smart Grid Transmission and Distribution
- Induction Heating and Welding

Absolute Maximum Ratings (At T _C = 25°C Unless Otherwise Stated)						
Parameter	Symbol	Conditions	Values	Unit	Note	
Drain-Source Voltage	$V_{DS(max)}$	V_{GS} = 0 V, I_D = 100 μA	1200	V		
Gate-Source Voltage (Dynamic)	V _{GS(max)}		-10 / +22	V		
Cata Cauraa Valtaga (Statia)	V _{GS(op)-ON}	Recommended Operation	18	V	Note 1	
Gate-Source Voltage (Static)	V _{GS(op)-OFF}	neconfinenced operation	-5 to -3	V	Note 1	
		$T_C = 25^{\circ}C$, $V_{GS} = -5 / +18 V$	31			
Continuous Drain Current	I_{D}	$T_C = 100$ °C, $V_{GS} = -5 / +18 V$	22	Α	Fig. 16	
		$T_C = 135^{\circ}C$, $V_{GS} = -5 / +18 V$	16			
Pulsed Drain Current	I _{D(pulse)}	$t_P \le 3\mu s$, $D \le 1\%$, $V_{GS} = 18 \text{ V}$	72	Α	Note 2	
Power Dissipation	P _D	$T_c = 25^{\circ}C$	140	W	Fig. 17	
Non-Repetitive Avalanche Energy	E _{AS}	$L = 36 \text{ mH}, I_{AV} = 3 \text{ A}$	162	mJ		
Operating Junction and Storage Temperature	T_j , T_{stg}		-55 to 175	°C		

Note 1: This product can support 0V turn-off gate drive voltage with optimized PCB layout and gate drive circuit configuration.

Note 2: Pulse Width tp Limited by T_{j(max)}



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Electrical Characteristics (At	T _C = 25°C Unle	ess Otherwise Stated)					
Parameter	Symbol	Conditions -	Values			Unit	Note
	Syllibol		Min.	Тур.	Max.	UIIIL	Note
Drain-Source Breakdown Voltage	V_{DSS}	$V_{GS} = 0 \text{ V, } I_D = 100 \mu\text{A}$	1200			V	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}$		1	50	μΑ	
Gate Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS} = 22 V			100	nA	
		$V_{DS} = 0 \text{ V, } V_{GS} = -10 \text{ V}$			-100		
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 9 \text{ mA}$	2.2	2.9	4.3	V	Note 3
Transconductance	g fs	$V_{DS} = 10 \text{ V, } I_D = 12 \text{ A}$		6.7		S	Fig. 5
		$V_{DS} = 10 \text{ V, } I_D = 12 \text{ A, } T_j = 175^{\circ}\text{C}$		7.0			
Drain-Source On-State Resistance	R _{DS(ON)}	$V_{GS} = 18 \text{ V, } I_D = 12 \text{ A}$		75	100	mΩ	Fig. 6-9
	. ,	V_{GS} = 18 V, I_D = 12 A, T_j = 175°C		130			
Input Capacitance	C _{iss}			988			Fig. 12
Output Capacitance	Coss			44		pF	
Reverse Transfer Capacitance	C _{rss}			4.6			
Coss Stored Energy	Eoss	- V _{DS} = 800 V, V _{GS} = 0 V		17		μJ	Fig. 13
Coss Stored Charge	Qoss	f = 500 KHz, V _{AC} = 25mV		62		nC	
Effective Output Capacitance (Energy Related)	$C_{o(er)}$	_		53		"Г	Note 4
Effective Output Capacitance (Time Related)	C _{o(tr)}			78	pF		Note 4
Gate-Source Charge	Q_{gs}	$V_{DS} = 800 \text{ V, } V_{GS} = -5 / +18 \text{ V}$		12			
Gate-Drain Charge	Q_{gd}	I _D = 12 A		12		nC	Fig. 11
Total Gate Charge	Q_g	Per JEDEC JEP-192		48			
Internal Gate Resistance	R _{G(int)}	$V_{GS} = 18 \text{ V, } f = 1 \text{ MHz, } V_{AC} = 25 \text{ mV}$		1.1		Ω	
Turn-On Switching Energy (Body Diode)	E _{On}	$T_j = 25$ °C, $V_{GS} = -5/+18V$, $R_{G(ext)} = 8 \Omega$, L =		90		1	Fin 04 07
Turn-Off Switching Energy (Body Diode)	E _{Off}	80.0 μH, I _D = 12 A, V _{DD} = 800 V		23		μJ	Fig. 24-27
Turn-On Delay Time	t _{d(on)}			20 9			Fig. 26
Rise Time	t _r	$V_{DD} = 800 \text{ V}, V_{GS} = -5/+18 \text{ V}$					
Turn-Off Delay Time	t _{d(off)}	$R_{G(ext)}$ = 8 Ω, L = 80.0 μH, I_D = 12 A		17		ns	Fig. 26
·	eu(OII)	 Timing relative to V_{DS}, Inductive load 					

Note 3: Tested after applying 30ms pulse at Vgs= +25V

Note 4: $C_{O(er)}$, a lumped capacitance that gives same stored energy as C_{OSS} while V_{DS} is rising from 0 to 800V. $C_{O(tr)}$, a lumped capacitance that gives same charging times as C_{OSS} while V_{DS} is rising from 0 to 800V.

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Reverse Diode Characteristics							
Parameter	Symbol	Conditions		Values			Note
	Syllibol	Conditions	Min.	Тур.	Max.	Unit	Note
Diode Forward Voltage	V_{SD}	V_{GS} = -5 V, I_{SD} = 6 A		4.4		V	Fig. 10 10
	VSD	V_{GS} = -5 V, I_{SD} = 6 A, T_j = 175°C		4.0		V	Fig. 18-19
Continuous Diode Forward Current	1.	$V_{GS} = -5 \text{ V, } T_c = 25^{\circ}\text{C}$			21	Α	
	ls	V_{GS} = -5 V, T_c = 100°C			13		
Diode Pulse Current	I _{S(pulse)}	V _{GS} = -5 V		52		Α	Note 2
Reverse Recovery Time	t _{rr}	V 5VI 10 A V 000 V		12		ns	
Reverse Recovery Charge	Qrr	V _{GS} = -5 V, I _{SD} = 12 A, V _R = 800 V dif/dt = 1200 A/µs, T _i = 25°C		51		nC	
Peak Reverse Recovery Current	I _{rrm}	uii/ut = 1200 A/μs, 1] = 25 C		3.5		Α	
Reverse Recovery Time	t _{rr}	V 5VI 10.1 V 000V		18		ns	
Reverse Recovery Charge	Q _{rr}	$V_{GS} = -5 \text{ V, } I_{SD} = 12 \text{ A, } V_{R} = 800 \text{ V}$ $dif/dt = 1200 \text{ A/}\mu\text{s, } T_{i} = 175^{\circ}\text{C}$		126		nC	
Peak Reverse Recovery Current	I _{rrm}	uii/ut - 1200 A/μs, 1 _J - 175 C		5.6		Α	

Package Characteristics					
Parameter	Symbol	Conditions	Values	Unit	Note
Max Thermal Resistance, Junction - Case	R _{th} JC-Max	Maximum	1.07	°C/W	Fig. 14
Weight	\mathbf{W}_{T}		1.45	g	
Moisture Sensitivity Level	MSL		1		
EMC Material Group			II		

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Fig 1: Typical Output Characteristics ($T_j = 25$ °C)

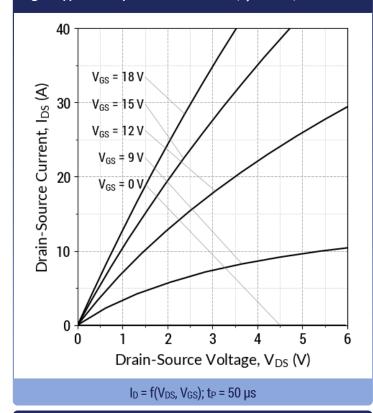
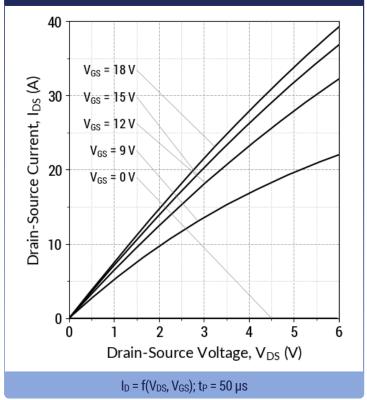


Fig 2: Typical Output Characteristics (T_j = 175°C)



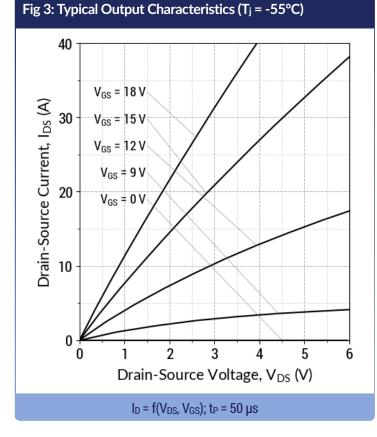
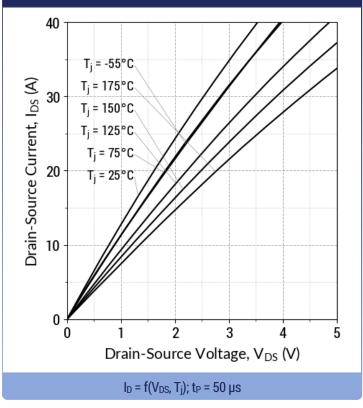
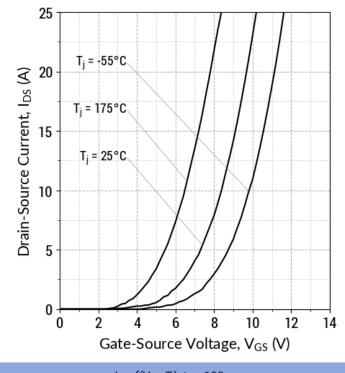


Fig 4: Typical Output Characteristics (V_{GS} = 18 V)



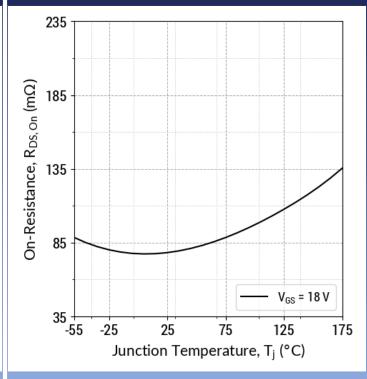
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Fig 5: Typical Transfer Characteristics (V_{DS} = 10 V)



 $I_D = f(V_{GS}, T_j); t_P = 100 \mu s$

Fig 6: Typical R_{DS(ON)} v/s Temperature



 $R_{DS(ON)} = f(T_j, V_{GS}); t_P = 50 \mu s; I_D = 12 A$

Fig 7: Typical RDS(ON) v/s Drain Current

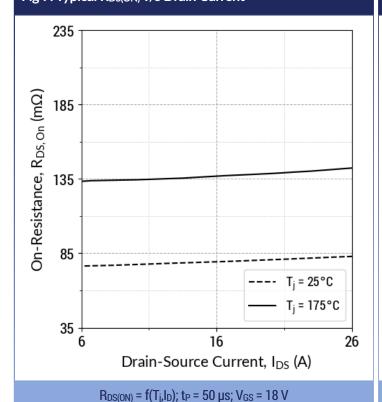
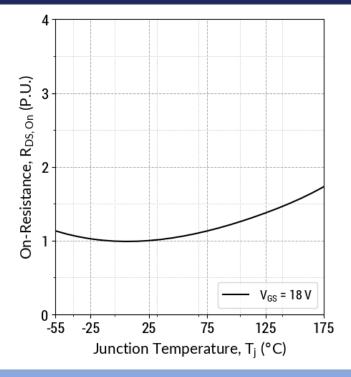


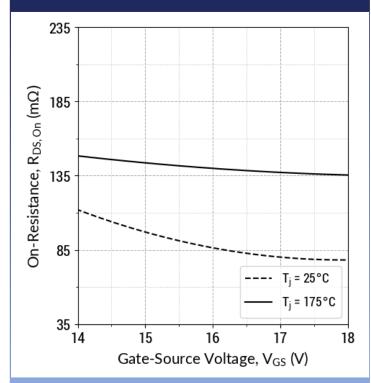
Fig 8: Typical Normalized RDS(ON) v/s Temperature



 $R_{DS(ON)} = f(T_j); t_P = 50 \mu s; I_D = 12 A$

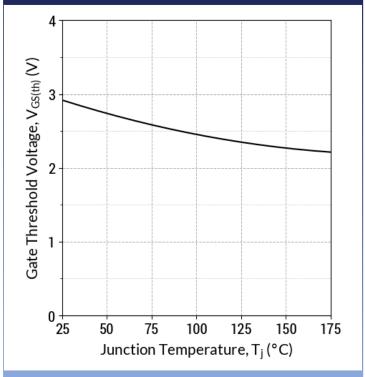
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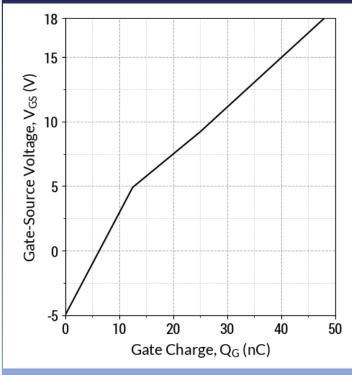
 $R_{DS(ON)} = f(T_j, V_{GS}); t_P = 50 \mu s; I_D = 12 A$

Fig 10: Typical Threshold Voltage Characteristics



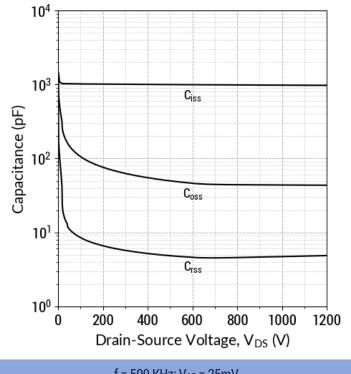
 $V_{GS(th)} = f(T_j)$; $V_{DS} = V_{GS}$; $I_D = 9 \text{ mA}$

Fig 11: Typical Gate Charge Characteristics



 $I_D = 12 A$; $V_{DS} = 800 V$; $T_c = 25$ °C

Fig 12: Typical Capacitance v/s Drain-Source Voltage



 $f = 500 \text{ KHz}; V_{AC} = 25 \text{mV}$

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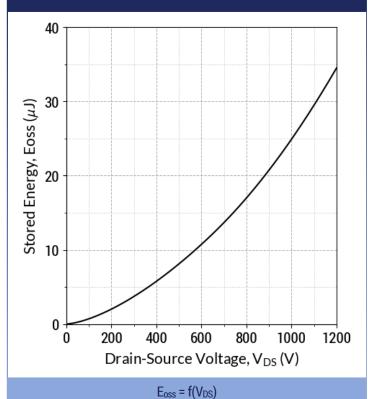
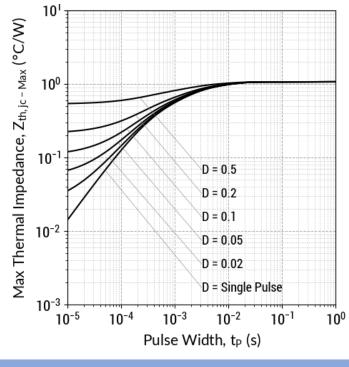


Fig 14: Max. Transient Thermal Impedance



 $Z_{th,ic} = f(t_P,D); D = t_P/T$

Fig 15: Safe Operating Area ($T_c = 25$ °C)

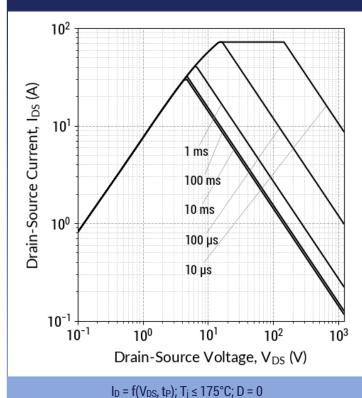
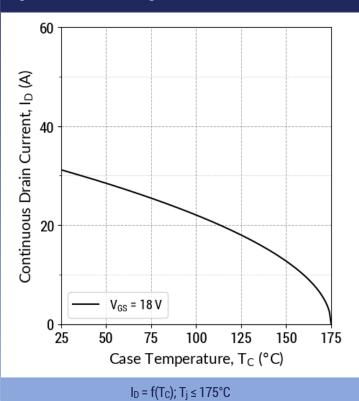
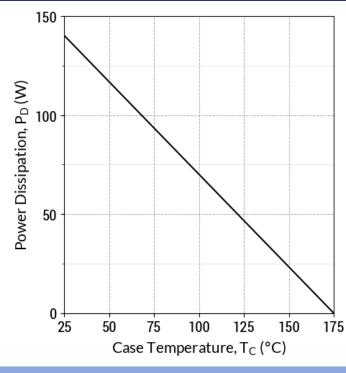


Fig 16: Current De-rating Curve



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 $P_D = f(T_C); T_j \le 175^{\circ}C$

Fig 18: Typical Body Diode Characteristics ($T_j = 25$ °C)

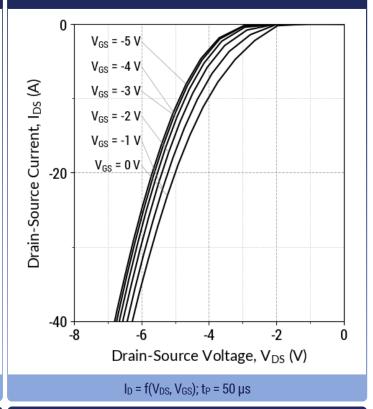


Fig 19: Typical Body Diode Characteristics (T_j = 175°C)

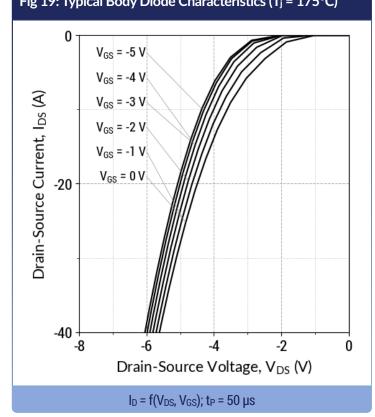
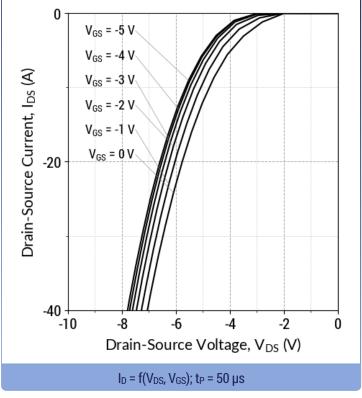


Fig 20: Typical Body Diode Characteristics ($T_j = -55$ °C)



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Fig 21: Typical Third Quadrant Characteristics ($T_j = 25$ °C)

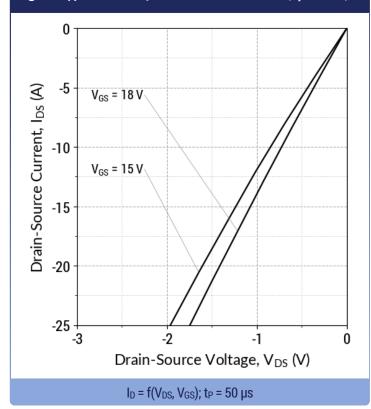


Fig 22: Typical Third Quadrant Characteristics ($T_j = 175^{\circ}$ C)

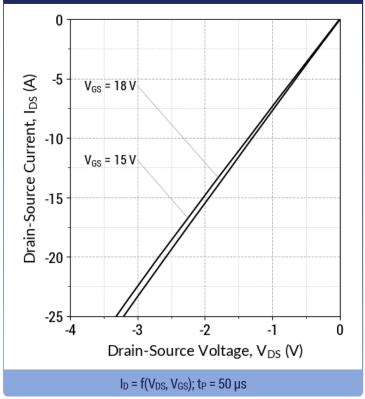


Fig 23: Typical Third Quadrant Characteristics (T_j = -55°C)

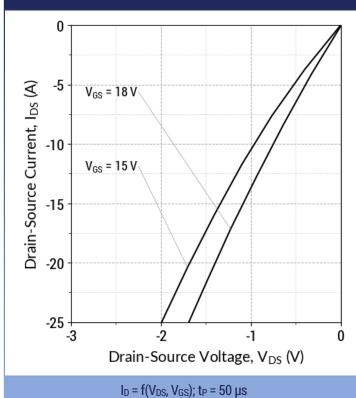
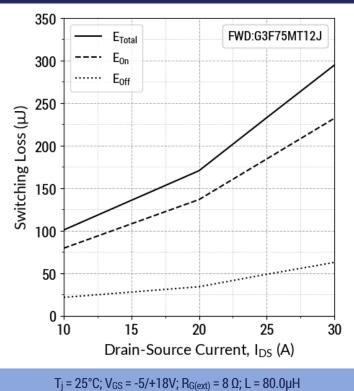
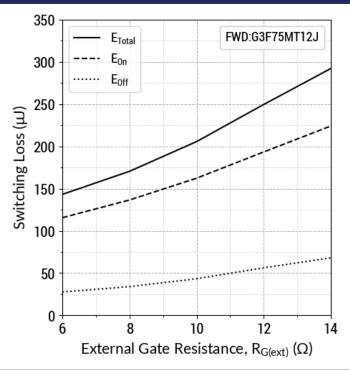


Fig 24: Inductive Switching Energy v/s Drain Current $\overline{(V_{DD}} = 800V)$



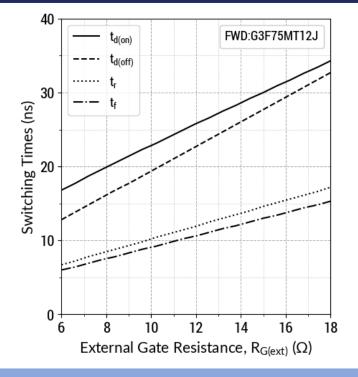
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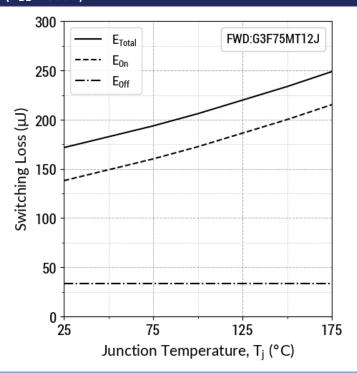
 $T_i = 25$ °C; $V_{GS} = -5/+18V$; $I_{DS} = 12$ A; $L = 80.0 \mu H$

Fig 26: Switching Time v/s R_{G(ext)} (V_{DD} = 800V)



 $T_i = 25$ °C; $V_{GS} = -5/+18V$; $I_{DS} = 12$ A; $L = 80.0 \mu H$

Fig 27: Inductive Switching Energy v/s Temperature $(V_{DD} = 800V)$

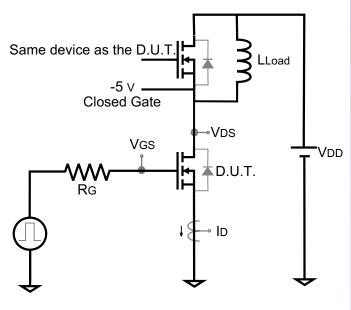


 $T_j = 25^{\circ}C$; $V_{GS} = -5/+18V$; $R_{G(ext)} = 8 \Omega$; $I_{DS} = 12 A$; $L = 80.0 \mu H$

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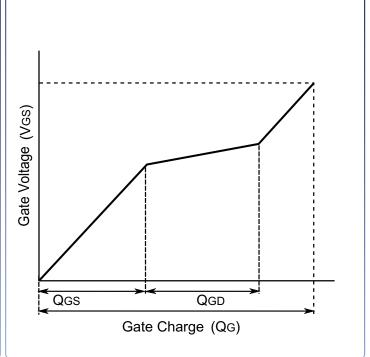


Dynamic Test Circuit

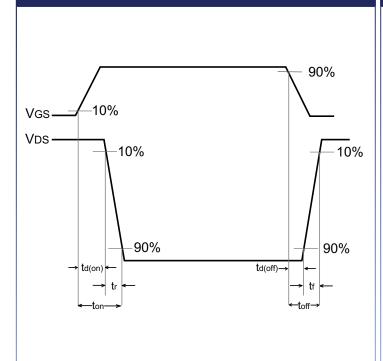


Note: Gate Charge, Switching Time and Energy Circuit

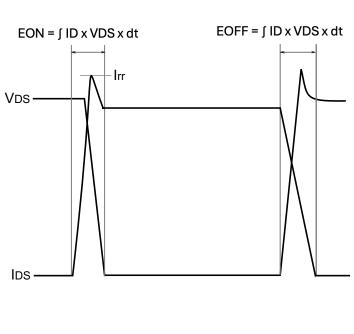
Gate Charge Waveform



Switching Time Waveform



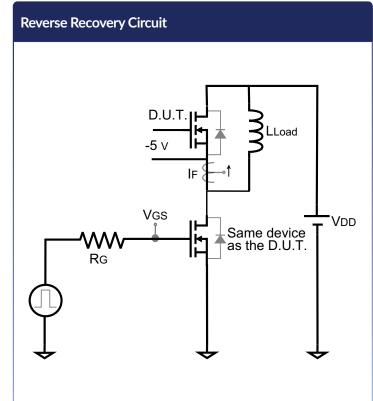
Switching Energy Waveform

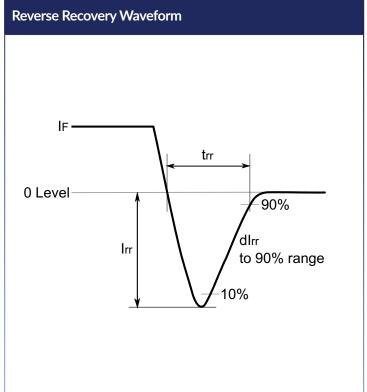


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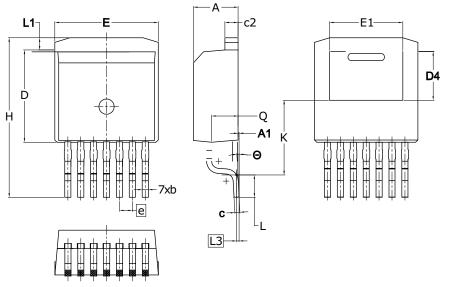
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Package Dimensions

TO-263-7 Package Outline



- 1. All Dimensions Are In mm.
- Dimension D & E Do Not Include Mold Flash.
 These Dimensions Are Measured At The Outermost
- Extreme Of The Plastic Body.

 3. Thermal Pad Contour Optional Within Dimensions E, L1, D4 & E1.

 4. Dimension D4 & E1 Establish A Minmum Mounting Surface for The Thermal Pad.

 5. is Exposed Cu.
- 6. There Is Exposed Cu and Molding Flash Bleeding At The Pin Which Is Close To Package.

SYMBOL	DIMENSIONS				
SYMBOL	MIN.	MAX.			
А	4.30	4.50			
A1	0.00	0.25			
b	0.50	0.70			
С	0.45				
c2	1.20 1.				
D	8.93 9				
D4	4.65	4.95			
E	10.08	10.28			
E1	6.82 7.6				
е	1.27 BSC				
Н	15.00 16				
К	7.30				
L	1.90	2.50			
L1	1.00 1.40				
L3	0.25 BSC				
Q	2.45 2.7				
Θ	0° 7°				

NOTE

- 1. CONTROLLED DIMENSION IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.
- 3. THE SOURCE AND KELVIN-SOURCE PINS ARE NOT INTERCHANGABLE. THEIR EXCHANGE MIGHT LEAD TO MALFUNCTION.

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Revision History

Rev 24/Aug: Initial Release (Rev 1.0)

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